

L Number	Hits	Search Text	DB	Time stamp
7	70	((defect\$4 fault\$4 deteriorat\$4 fail\$4) with (tft thin adj film adj transistor) with (profile storage stored))	USPAT; US-PGPUB	2004/10/15 15:24
8	1421	((tft thin adj film adj transistor) with (manufacture fabricat\$4)).ti,ab,clm.	USPAT; US-PGPUB	2004/10/15 15:25
9	6	((defect\$4 fault\$4 deteriorat\$4 fail\$4) with (tft thin adj film adj transistor) with (profile storage stored)) and (((tft thin adj film adj transistor) with (manufacture fabricat\$4)).ti,ab,clm.)	USPAT; US-PGPUB	2004/10/15 15:25
10	13	("4175253" "4290013" "4342959" "4801869" "4819038" "4843312" "4894605" "4940934" "5057775" "5072175" "5113134" "5179345" "5377030").PN.	USPAT	2004/10/15 15:42
-	86	(apply\$4 inject\$4) with (tft thin adj film adj transistor) same (measur\$4 detect\$4 monitor\$4) with voltage	USPAT; US-PGPUB	2004/10/15 10:40
-	23	((defect\$4 fault\$4 deteriorat\$4 fail\$4) with (classif\$5 determin\$4 detect\$4) with (tft thin adj film adj transistor)).ti,ab,clm.	USPAT; US-PGPUB	2004/10/15 15:23
-	4	((apply\$4 inject\$4) with (tft thin adj film adj transistor) same (measur\$4 detect\$4 monitor\$4) with voltage) and (((defect\$4 fault\$4 deteriorat\$4 fail\$4) with (classif\$5 determin\$4 detect\$4) with (tft thin adj film adj transistor)).ti,ab,clm.)	USPAT; US-PGPUB	2004/10/15 14:45
-	1	5377030.pn.	USPAT; US-PGPUB	2004/10/15 10:49